

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination CHAN ET AL.	
		Examiner Fazli Erdem	Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,483,171	11-2002	Forbes et al.	257/627
B	US-2002/0063292	05-2002	Armstrong et al.	257/367
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 01076755	09-1987	Japan	Yasukawa	H01L027/08
O	JP 411354394	12-1999	Japan	Sawada	H01L021/02
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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